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# LitePoint Acquires ZTEC Instruments

## Expanding Market Focus to include Design Verification Testing

**Sunnyvale, California – October 29, 2013** – LitePoint, a leading provider of wireless test solutions, announced today that it has completed the acquisition of privately-held ZTEC Instruments, a manufacturer of innovative modular wireless test products, located in Albuquerque, New Mexico and Orlando, Florida.

“Our goal is always to provide the right test solution for the job being done,” said Brad Robbins, COO of LitePoint. “LitePoint provides innovative solutions designed for testing wireless devices in manufacturing. ZTEC’s cutting-edge solutions are uniquely designed for testing wireless devices at the design verification stage, in a flexible PXI form factor. We’ve combined that technology with LitePoint’s powerful modulation software, enabling us to provide the wireless industry a peerless solution for design verification testing of components and chipsets. This also enables easy correlation from design verification to high-volume production testing – something that has increasing importance as device makers are tasked with producing in larger volumes and at faster speeds than ever before.”

Chris Ziomek, founder and CEO of ZTEC added, “Wireless chipset suppliers use our flexible PXI-based platform for high-performance RF design verification testing. Combined with LitePoint’s systems, our complete, end-to-end solution will shorten the time-to-market for today’s most innovative and market-leading wireless products.”

“In the aerospace and defense market, ZTEC’s proven, high-performance instruments are a natural fit with Teradyne’s global Systems Test business,” said John Wood, General Manager for the business. “By combining ZTEC’s instruments with Teradyne’s Core System Instruments, we will deliver a highly integrated solution for testing of today’s complex aerospace and defense systems.”

